

SONY**CX23034**

Digital Filter for CD

Description

The CX23034 is a silicon gate CMOS LSI which has been developed as a digital filter for compact disc player. Excellent filter characteristics can easily be realized by inserting CX23034 between digital signal processing LSI CX23035 for CD and D/A converter.

Features

- Composition of filter:
 - Stereo signal processing with 1 chip
 - Two times sampling rate conversion
 - FIR filter with 16-bit coefficient
 - Filter length 96
- Characteristics of filter:
 - Linear phase
 - Band passing ripple lower than +0.01 dB
 - Stopband attenuation higher than 80 dB
 - Frequency characteristics designed to correct the aperture effect of D/A converter
- Overflow limiter
- Formats of the output data can be selected either to two's complement or offset binary
- Interface possible with 16-bit serial input D/A converter
- Use together with CX23035 in pair

Structure

Silicon gate CMOS

Absolute Maximum Ratings ($T_a=25^\circ\text{C}$)

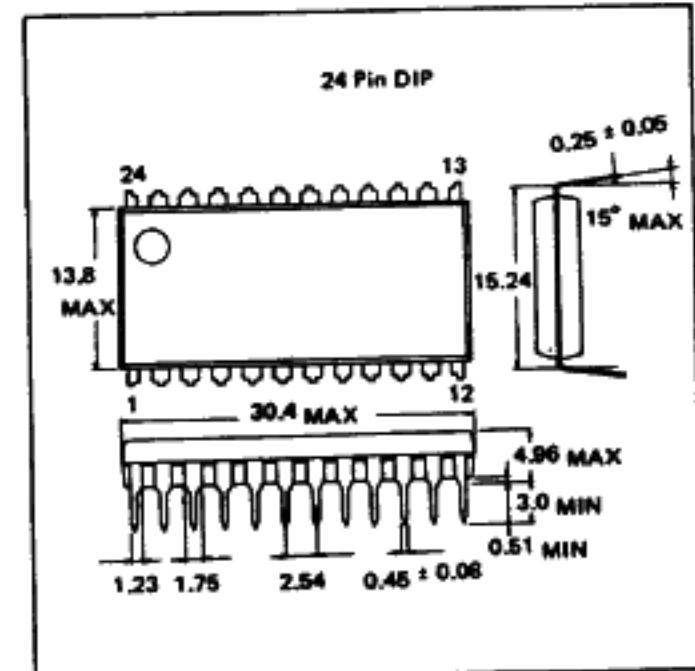
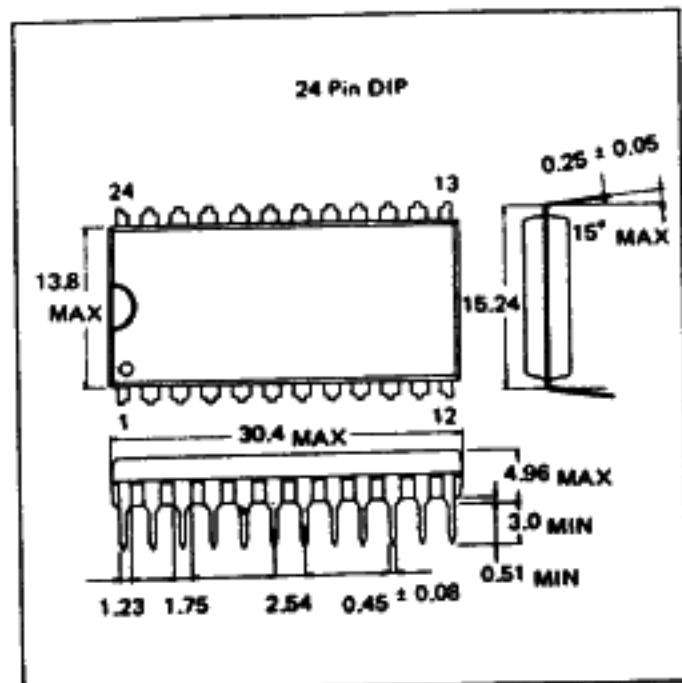
- Power supply voltage V_{DD} V_{SS}^* -0.3 to $+7.0$ V
 - Input voltage V_{IN} V_{SS}^* -0.3 to $+7.0$ V
 - Output voltage V_{OUT} V_{SS}^* -0.3 to $+7.0$ V
 - Operating temperature T_{OPR} -20 to $+75$ $^\circ\text{C}$
 - Storage temperature T_{STG} -55 to $+150$ $^\circ\text{C}$
- * $V_{SS} = 0$ V

Recommended Operating Conditions

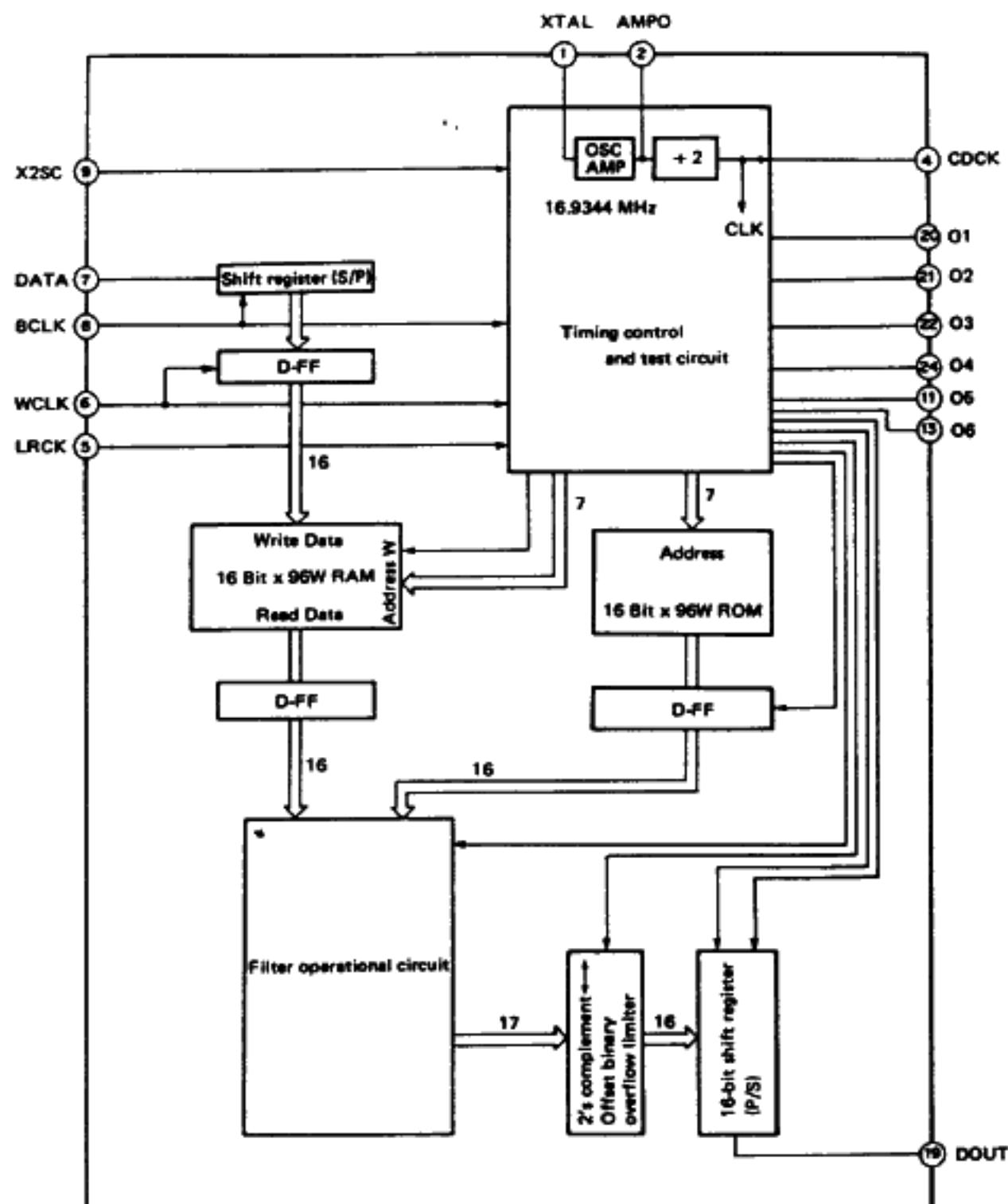
- Power supply voltage V_{DD} 4.5 to 5.5 V
- Input voltage V_{IN} V_{SS} -0.3 to $V_{DD} + 0.3$ V
- Operating temperature T_{OPR} -20 to $+75$ $^\circ\text{C}$

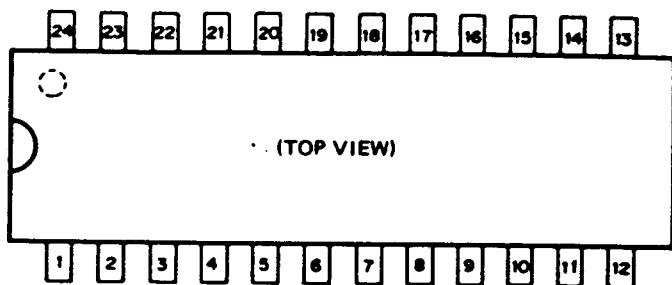
Package Outline

Unit: mm



Block diagram



Pin Configuration**Pin Description**

Pin No.	Symbol	I/O	Description
1	XTAL	I	Input for crystal oscillator (16.9344 MHz)
2	AMPO	O	Output for crystal oscillator (16.9344 MHz)
3	TSET1	I	Input for testing (Normally connected to Vss)
4	CDCK	O	Clock output (8.4672 MHz)
5	LRCK	I	44.1 kHz strobe input
6	WCLK	I	88.2 kHz strobe input
7	DATA	I	Serial data input (Two's complement, MSB first)
8	BCLK	I	Bit clock input (input for serial data)
9	X2SC	I	Input for output format selection (High offset binary, low two's complement)
10	TEST2	I	Input for test (normally connected to Vss)
11	O5	O	Timing signal
12	Vss	—	GND pin (0V)
13	O6	O	Timing signal
14	TEST3	O	Test data output (normally open)
15	TEST4	O	Test data output (normally open)
16	TEST5	O	Test data output (normally open)
17	TEST6	O	Test data output (normally open)
18	TEST7	O	Test data output (normally open)
19	DOUT	O	Serial data output (MSB first)
20	O1	O	Timing signal
21	O2	O	Timing signal
22	O3	O	Timing signal
23	O4	O	Timing signal
24	Voo	—	Power supply pin (+5V)

Note) The frequencies shown are values to be used for CD.

Input/Output Capacity

Item	Symbol	Standard			Unit
		Min.	Typ.	Max.	
Input pin	C _{IN}		8	12	pF
Output pin	C _{OUT}		10	12	pF

Measuring condition: V_{DD}=V_{IN}=0V, FM=1 MHz**Electrical Characteristics****DC characteristics**V_{DD}=5V±10%, V_{SS}=0V, T_{OPR}=-20 to +75°C

Item	Symbol	Condition	Standard			Unit
			Min.	Typ.	Max.	
Supply current	I _{DD}	V _{DD} =5.0V		35		mA
	I _{DOS}	V _{DD} =5.0V V _{IH} =V _{DD} V _{IL} =V _{SS}			0.1	mA
Input voltage (1) H level	V _{IH1}		0.7V _{DD}			V
Input voltage (1) L level					0.3V _{DD}	V
Input voltage (2) H level	V _{IH2}		2.2			V
Input voltage (2) L level					0.8	V
Output voltage H level	V _{OH}	I _{OH} =1 mA	V _{DD} -0.5		V _{DD}	V
Output voltage L level		I _{OL} =1 mA	0		0.4	V
Input leakage current	B group (note)	I _U		-5		5 uA

Note) Pins of from A to C groups are shown as below.

A group	XTAL
B group	TEST1, TEST2, X2SC, DATA, BCLK, WCLK, LRCK
C group	CDCK, O1, O2, O3, O4, O5, O6, DOUT, TEST3, TEST4, TEST5, TEST6, TEST7

AC Characteristics

Input AC characteristics

Topr=−20 to +75°C, VDD=5V±10%

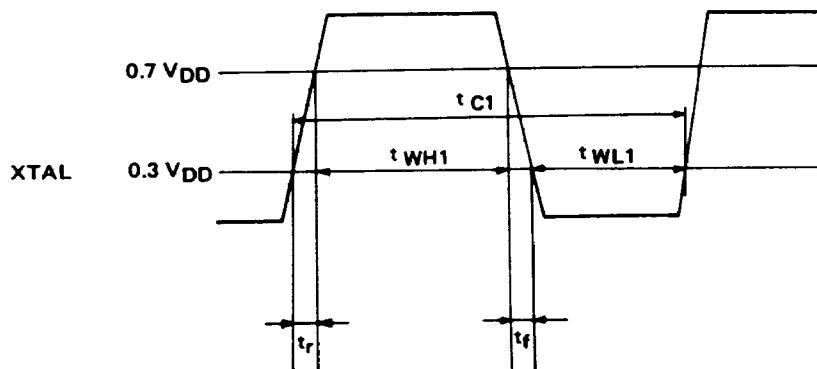
(1) XTAL pin

- ① In the event crystal oscillator is used

Item	Symbol	Min.	Typ.	Max.	Unit
Oscillating frequency	fMAX	..		18.432	MHz

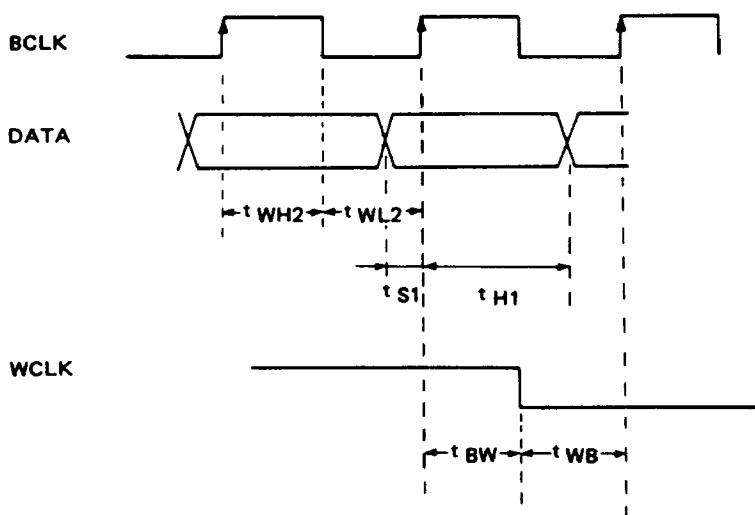
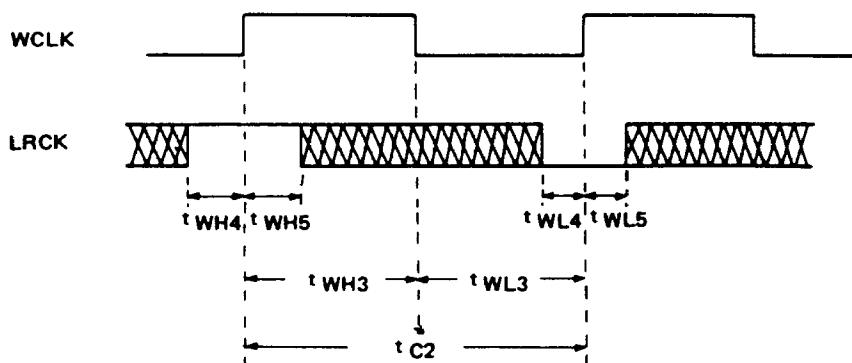
- ② In the event pulse is input while crystal oscillator is not being used

Item	Symbol	Min.	Typ.	Max.	Unit
Pulse cycle	tC1	54	59		ns
"H" level pulse width	tWH1	12	19.5		ns
"L" level pulse width	tWL1	12	19.5		ns
Rising time	tr		10	15	ns
Falling time	tf		10	15	ns



(2) DATA, BCLK, WCLK and LRCK pins

Item	Symbol	Min.	Typ.	Max.	Unit
BCLK "H" level pulse width	tWH2	59			ns
BCLK "L" pulse level width	tWL2	48			ns
DATA hotting-up time	tS1	13			ns
DATA holding time	tH1	59			ns
WCLK "H" level pulse width	tWH3	3543		7795	ns
WCLK "L" level pulse width	tWL3	3543		7795	ns
WCLK pulse cycle	tC2		11338		ns
From rising of BCLK to falling of WCLK	tBW	65			ns
From falling of WCLK to rising of BCLK	tWB	22			ns
LRCK "H" level pulse width 1	tWH4	0			ns
LRCK "H" level pulse width 2	tWH5	473			ns
LRCK "L" level pulse width 1	tWL4	0			ns
LRCK "L" level pulse width 2	tWL5	473			ns



Function Explanation

(1) Oscillation circuit

Connect a crystal oscillator with a oscillation frequency of 384 fs (16.9344 MHz) between XTAL pin and AMPO pin, as shown in Fig. 1. In the event crystal oscillation is not used, input clock signal with a frequency of 384 fs to the XTAL pin.

The clock signal of 192fs (8.4672 MHz), which is divided-by 2 of the crystal oscillation frequency, is output from the CDCK pin.

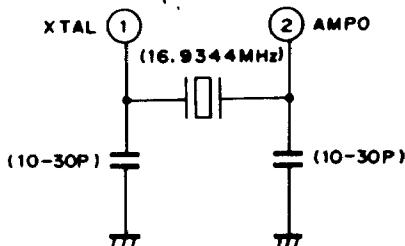


Fig. 1 Oscillation circuit

[The values shown in parentheses are those used for CD]

(2) Regarding initialization

The initialization of this LSI requires a XTAL time of approx. 770 clocks after the power supply is turned on, provided that all inputs are in normal condition. (It takes approx. 46 μ s when XTAL 16.9344 MHz.) The output is not valid until the initialization is completed.

(3) Interface with signal processing LSI

Interfacing with the signal processing LSI can be carried out as shown in Fig. 2.

The input data 16 bit (two's complement) is input to DATA pin with MSB first, and individual bits of DATA input are fetched into the shift register within the IC at rising of BCLK. Accordingly, individual bits of DATA input should be changed at the falling of BCLK. Thus, 16 bits of data in the shift register within the LSI at the falling of WCLK is latched as a writing data of RAM.

Therefore, BCLK signal requires at least 16 pulses during its falling time of WCLK to the next falling time of same. If the BCLK signal has 17 pulses or over during its falling time of WCLK to the next falling time of same, 16 bits before WCLK falling time become writing data of RAM.

The input data becomes L-ch signal when LRCK is "H", and R-ch signal when LRCK is "L".

(4) Interface with D/A converter

It enables to be interfaced with various D/A converter by using X2SC pin. The output timing chart is as shown in Fig. 2.

X2SC (Switchover of offset binary two's complement)

X2SC = "H" offset binary

X2SC = "L" two's complement

Offset binary is MSB inverse of two's complement.

(5) Regarding synchronizing with input and output signals

If the relative relation between rising of WCLK when LRCK is "L" and output signal differs by more than 2 clocks of CDCK (236 ns), the operation within the IC is momentarily stopped, and synchronization of input signal and output signal is performed again.

(6) Regarding frequency characteristics of filter

The frequency characteristics of this LSI are as shown in Figs. 3 and 4.

(7) Correction of aperture effect frequency characteristics of D/A converter

The digital output of this LSI is output after correcting the frequency characteristics against the aperture effect of the D/A converter. In addition, this correction is carried out on the assumption that the sample and hold type DEGRETER is used as an analog output of the D/A converter.

Timing Chart

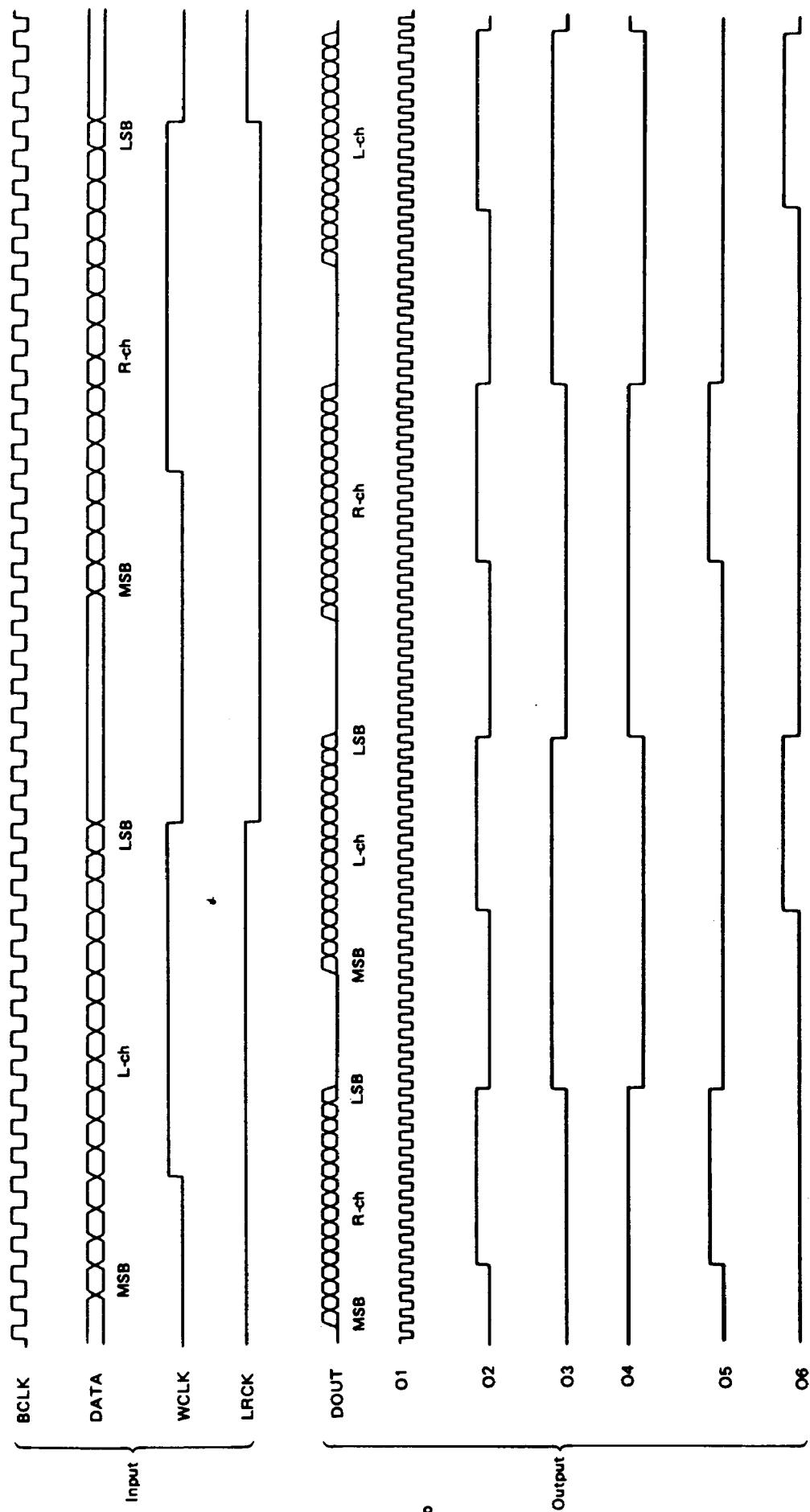


Fig. 2 CX23034 timing chart

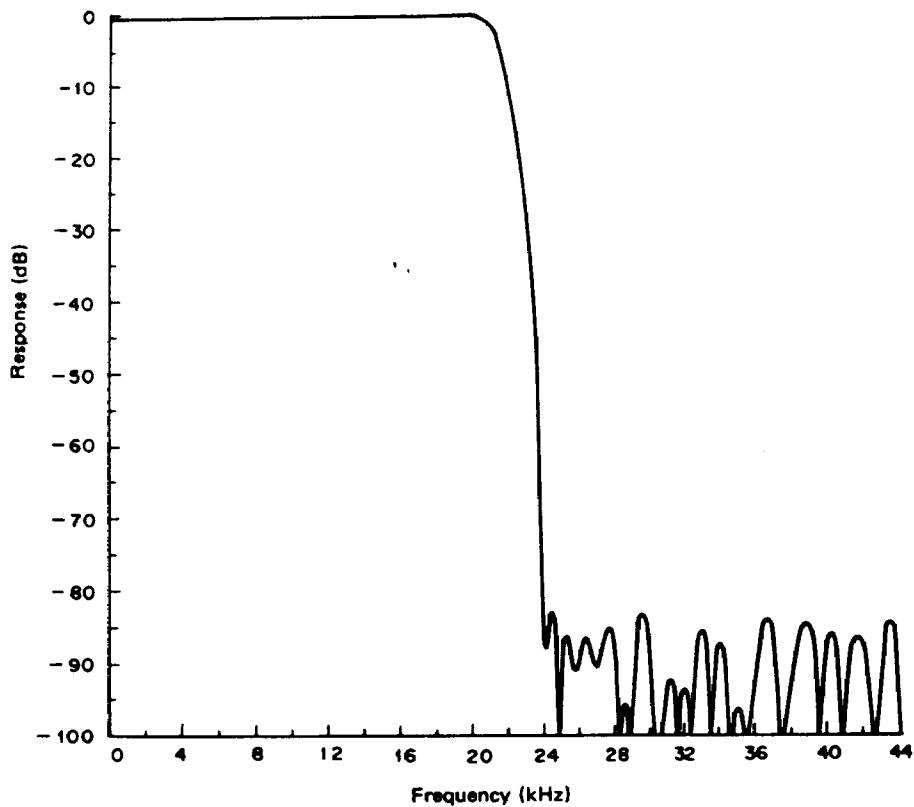


Fig. 3 Frequency characteristics

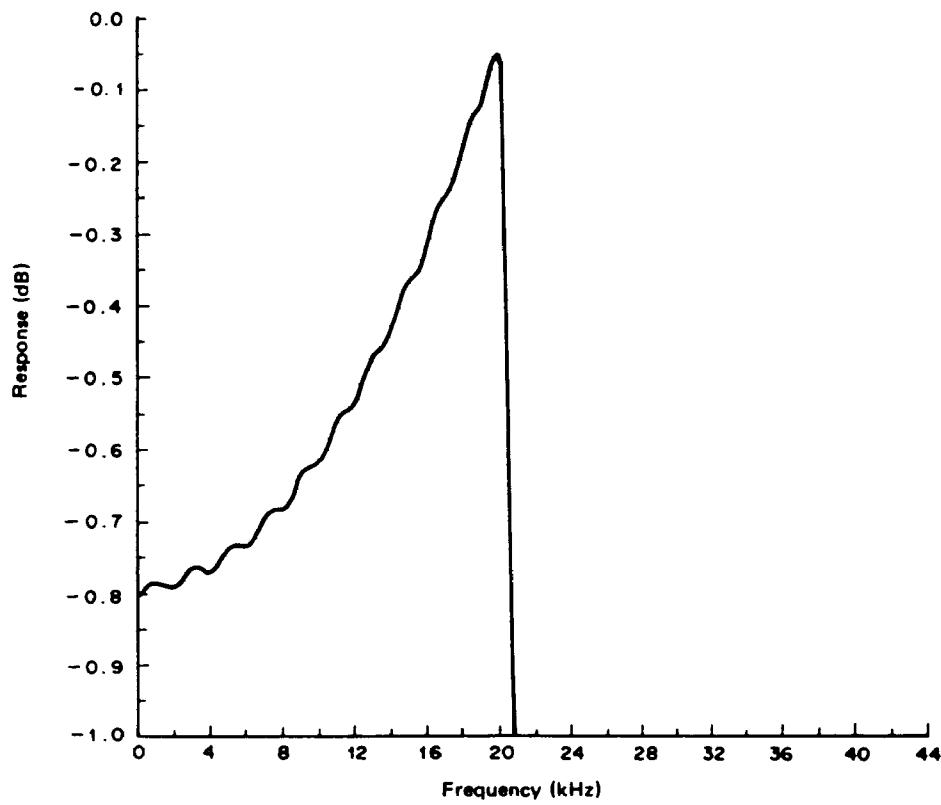
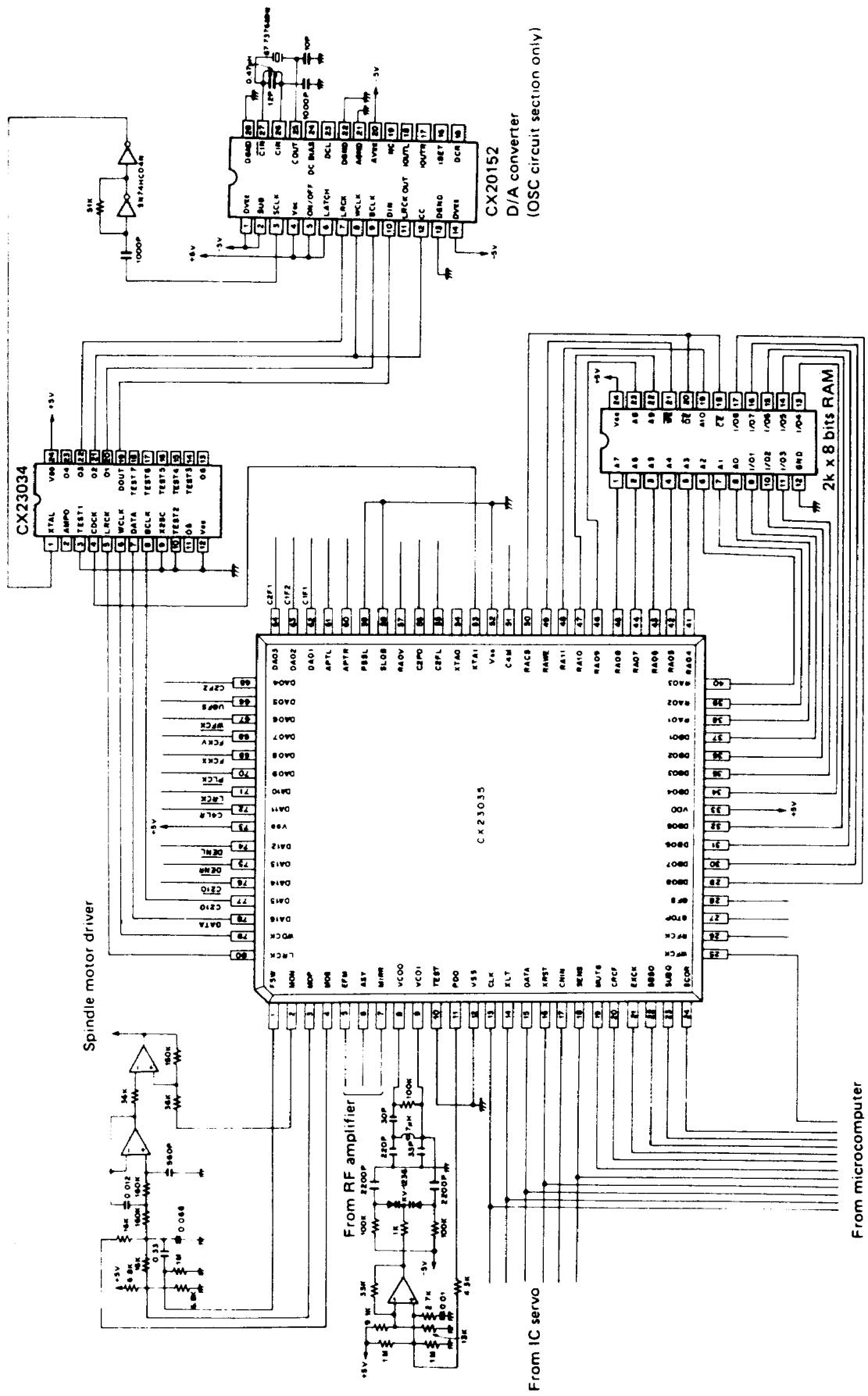


Fig. 4 Band passing characteristics

Example of Application Circuit

(1) Connection of CX23034, CX23035 and CX20152



(2) L-ch and R-ch same phase connection method

